

## Electronic Supplementary Information

### **Powder-based $(\text{CuGa}_{1-y}\text{In}_y)_{1-x}\text{Zn}_{2x}\text{S}_2$ solid solution photocathode with a largely positive onset potential for solar water splitting**

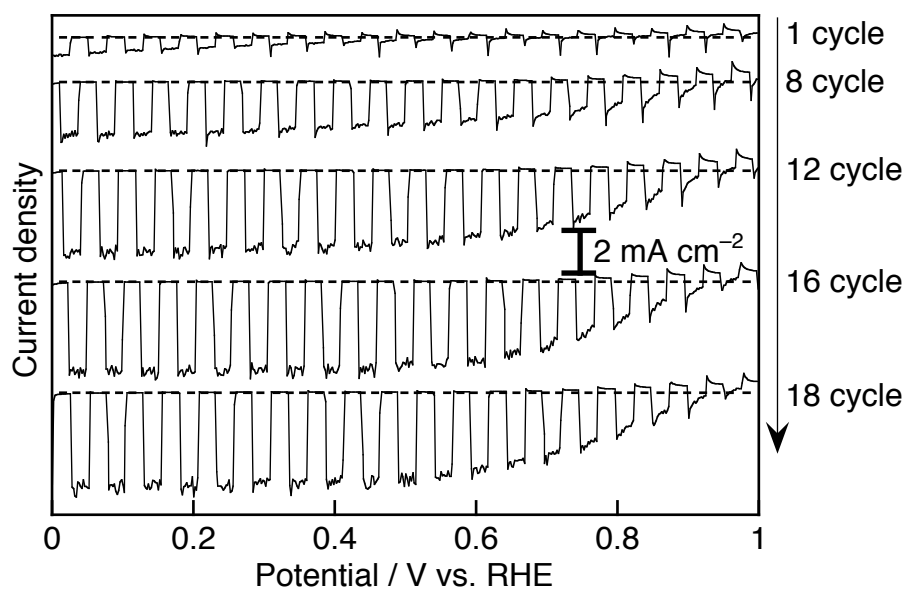
Toshio Hayashi,<sup>1,2</sup> Ryo Niishiro,<sup>1,2</sup> Hitoshi Ishihara,<sup>1</sup> Masaharu Yamaguchi,<sup>3</sup> Qingxin Jia,<sup>3</sup> Yongbo Kuang,<sup>3</sup> Tomohiro Higashi,<sup>3</sup> Akihide Iwase,<sup>4</sup> Tsutomu Minegishi,<sup>3</sup> Taro Yamada,<sup>3</sup> Kazunari Domen,<sup>3</sup> Akihiko Kudo<sup>4\*</sup>

<sup>1</sup>Japan Technological Research Association of Artificial Photosynthetic Chemical Process (ARPCHEM), 7-3-1 Hongo, Bunkyo-ku, Tokyo 113-8656, Japan.

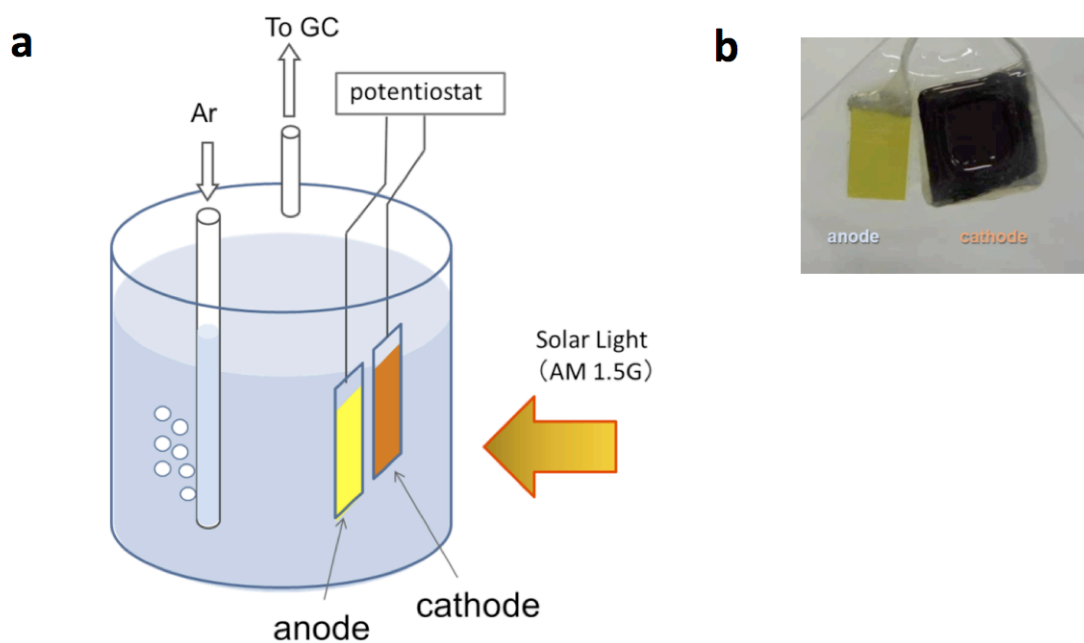
<sup>2</sup>Mitsui chemicals, Inc., 580-32 Nagaura, Sodegaura, 299-0265 Chiba, Japan.

<sup>3</sup>Department of Chemical System Engineering, The University of Tokyo, 7-3-1 Hongo, Bunkyo-ku, Tokyo 113-8656, Japan.

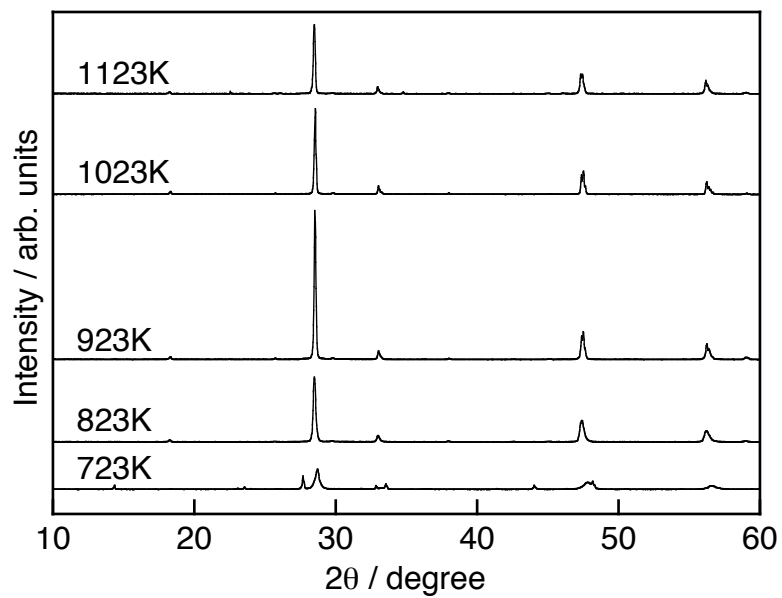
<sup>4</sup>Department of Applied Chemistry, Faculty of Science, Tokyo University of Science, 1-3 Kagurazaka, Shinjuku-ku, Tokyo 162-8601, Japan.



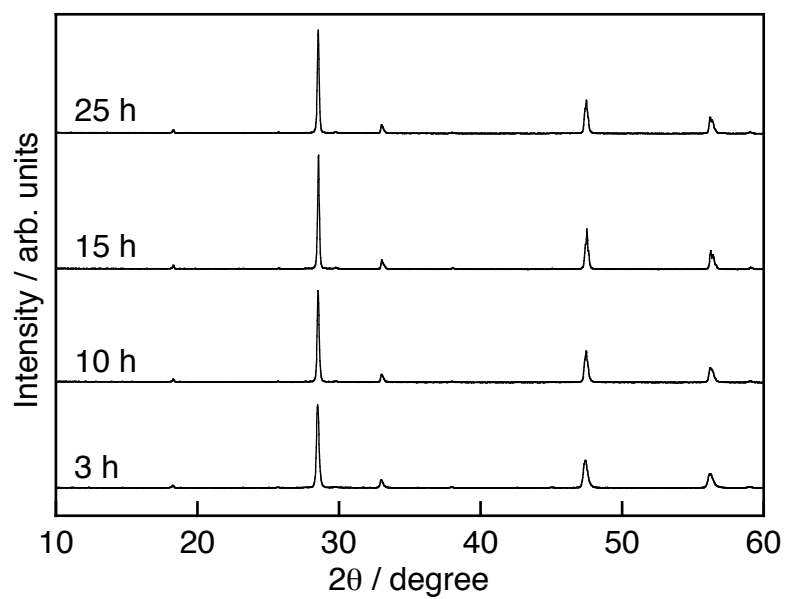
**Figure S1.** Typical  $I$ - $V$  curves of a Pt/CdS/CGIZS photocathode in an activation process before use by performing cyclic voltammetry between 0.0-1.0 V vs. RHE in an aqueous phosphate buffer solution (pH 6.4) under irradiation of simulated sunlight (AM 1.5G). The CGIZS represents  $\text{Cu}_{0.8}\text{Ga}_{0.4}\text{In}_{0.4}\text{Zn}_{0.4}\text{S}_2$  (Ga 20% excess) prepared by a flux method using LiCl-KCl (3:2) mixture at 823 K for 15 h.



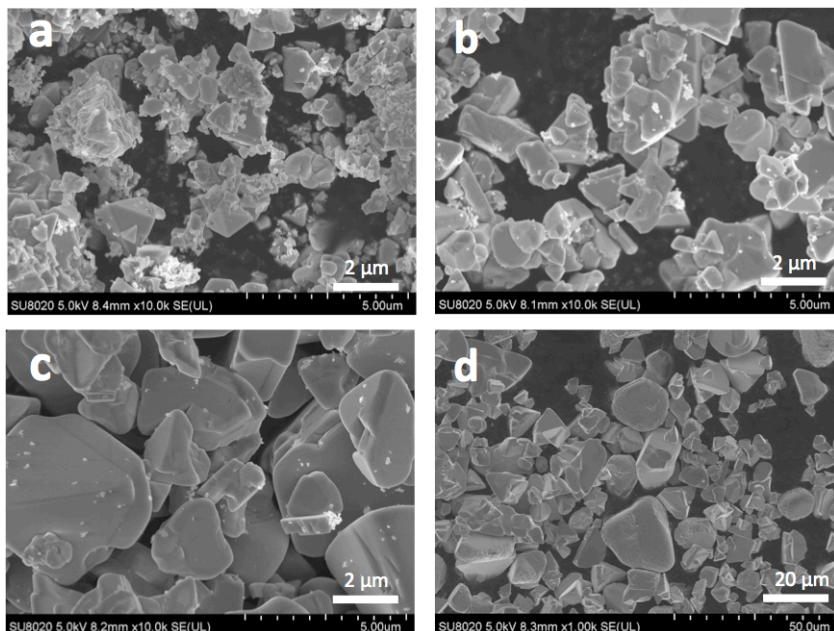
**Figure S2.** (a) Photoelectrochemical system equipped with on-line gas chromatography, two-electrode type. The photoanode and photocathode existed side by side in the same plane. (b) Photograph of Pt/TiO<sub>2</sub>/CdS/CGIZS/Au photocathode (0.231 cm<sup>2</sup>) and CoFeO<sub>x</sub>/BiVO<sub>4</sub>/ITO photoanode (0.272 cm<sup>2</sup>) used for overall water splitting.



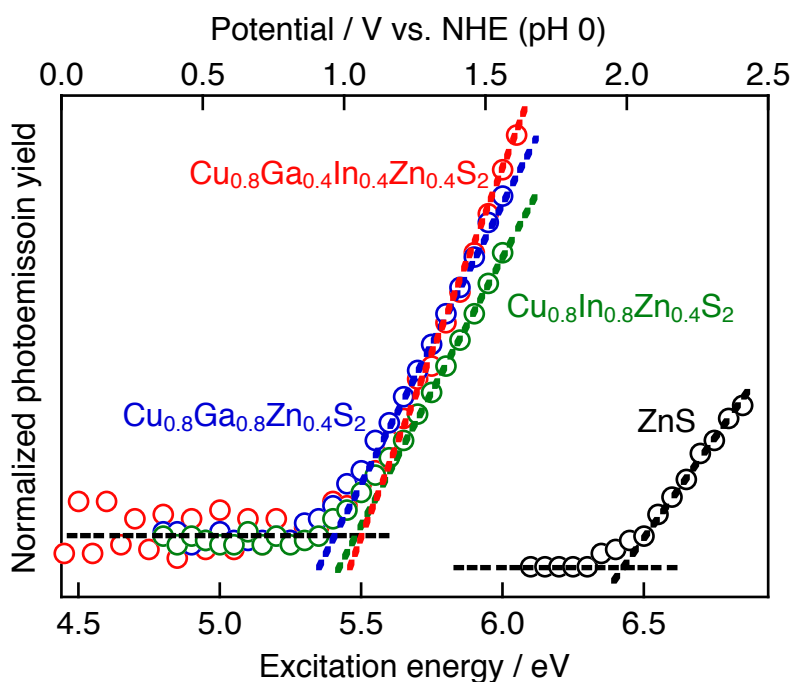
**Figure S3.** XRD patterns of  $\text{Cu}_{0.8}\text{Ga}_{0.4}\text{In}_{0.4}\text{Zn}_{0.4}\text{S}_2$  photocatalysts (Ga 20% excess) prepared by a flux method using LiCl-KCl (3:2) mixture for 3 h at 723 K, 823 K, 923 K, 1023 K, and 1123 K.



**Figure S4.** XRD patterns of  $\text{Cu}_{0.8}\text{Ga}_{0.4}\text{In}_{0.4}\text{Zn}_{0.4}\text{S}_2$  photocatalysts (Ga 20% excess) prepared by a flux method using LiCl-KCl (3:2) mixture at 823 K for 3 h, 10 h, 15 h and 25 h.

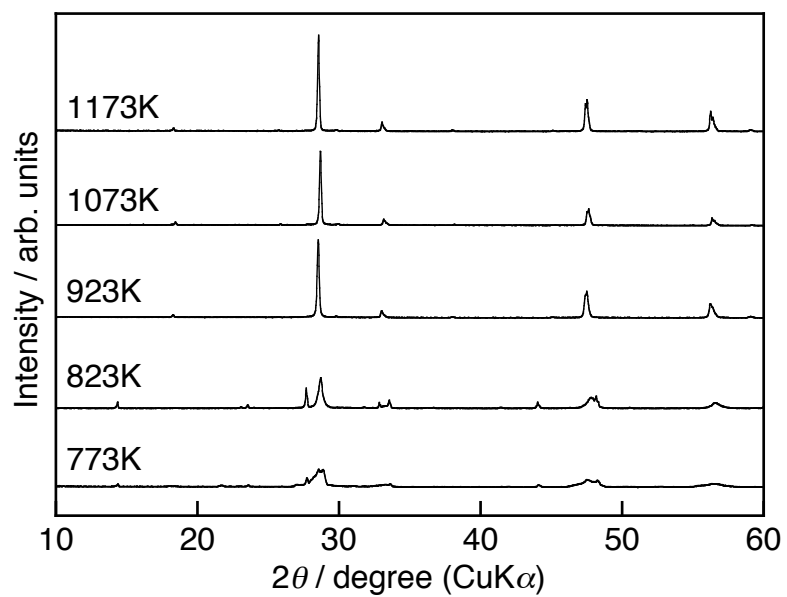


**Figure S5.** SEM images of  $\text{Cu}_{0.8}\text{Ga}_{0.4}\text{In}_{0.4}\text{Zn}_{0.4}\text{S}_2$  photocatalysts (Ga 30% excess) prepared by a flux method using LiCl-KCl (3:2) mixture for 15 h at (a) 723 K, (b) 823 K, (c) 923 K, and (d) 1023 K.



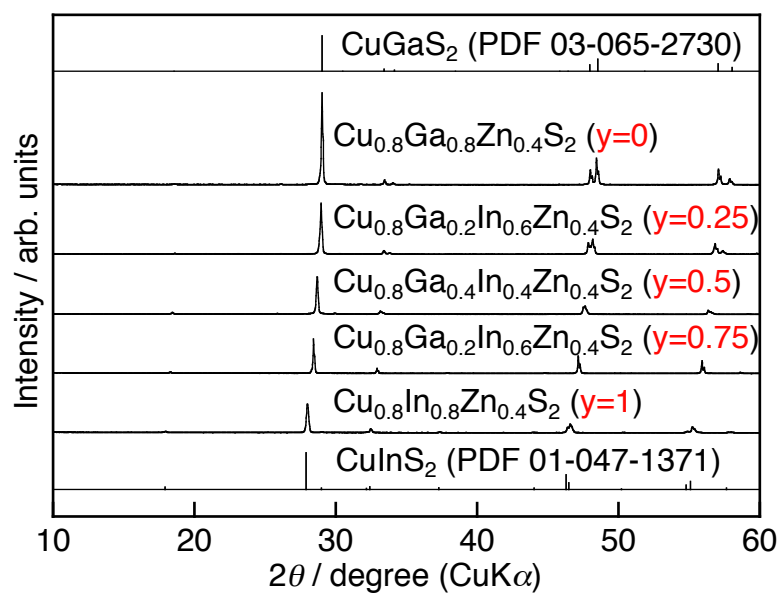
**Figure S6.** PESA (photoelectron spectroscopy in air) of  $(\text{CuGa}_{1-y}\text{In}_y)_{1-x}\text{Zn}_{2x}\text{S}_2$  photocatalysts (Ga 20% excess) prepared by a flux method using LiCl-KCl (3:2) mixture at 823 K for 15 h;  $x=0.2$ ,  $y=0.0$ ,  $\text{Cu}_{0.8}\text{Ga}_{0.8}\text{Zn}_{0.4}\text{S}_2$  (red),  $x=0.2$ ,  $y=0.5$ ,  $\text{Cu}_{0.8}\text{Ga}_{0.4}\text{In}_{0.4}\text{Zn}_{0.4}\text{S}_2$  (blue),  $x=0.2$ ,  $y=1.0$ ,  $\text{Cu}_{0.8}\text{In}_{0.8}\text{Zn}_{0.4}\text{S}_2$  (green), and  $x=1$ , ZnS (black).

PESA is similar to XPS and UPS. During the measurements, a sample is irradiated with a monochromatic ultraviolet light with energy of 4.0-7.0 eV. When the energy is larger than the work function of the sample, photoelectrons are emitted from the sample. In other words, photoelectrons start to emit at a certain energy level, when the energy of the irradiated ultraviolet light is gradually raised. The energy level corresponds to the valence band maximum in a semiconductor material.

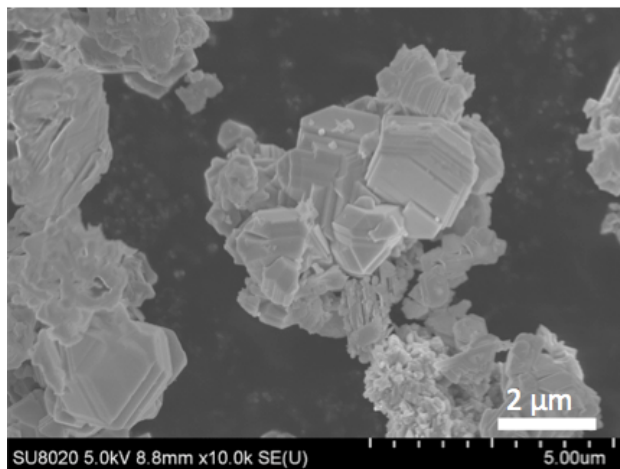


**Figure S7.** XRD patterns of  $\text{Cu}_{0.8}\text{Ga}_{0.4}\text{In}_{0.4}\text{Zn}_{0.4}\text{S}_2$  photocatalysts (Ga 20% excess) prepared by solid-state synthesis at 773 K, 823 K, 923 K, 1073 K, and 1173 K for 10 h.

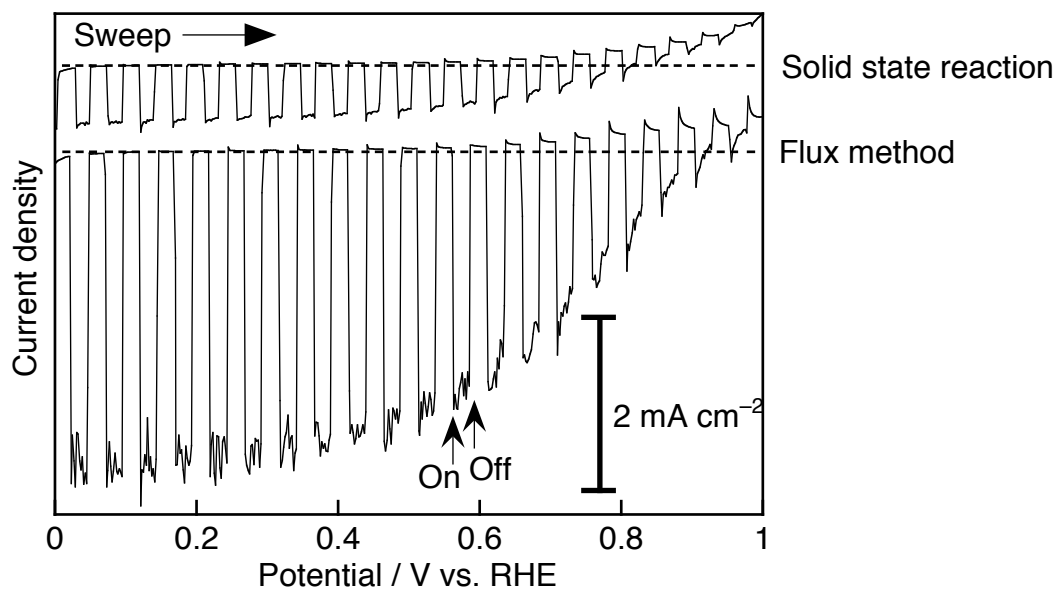




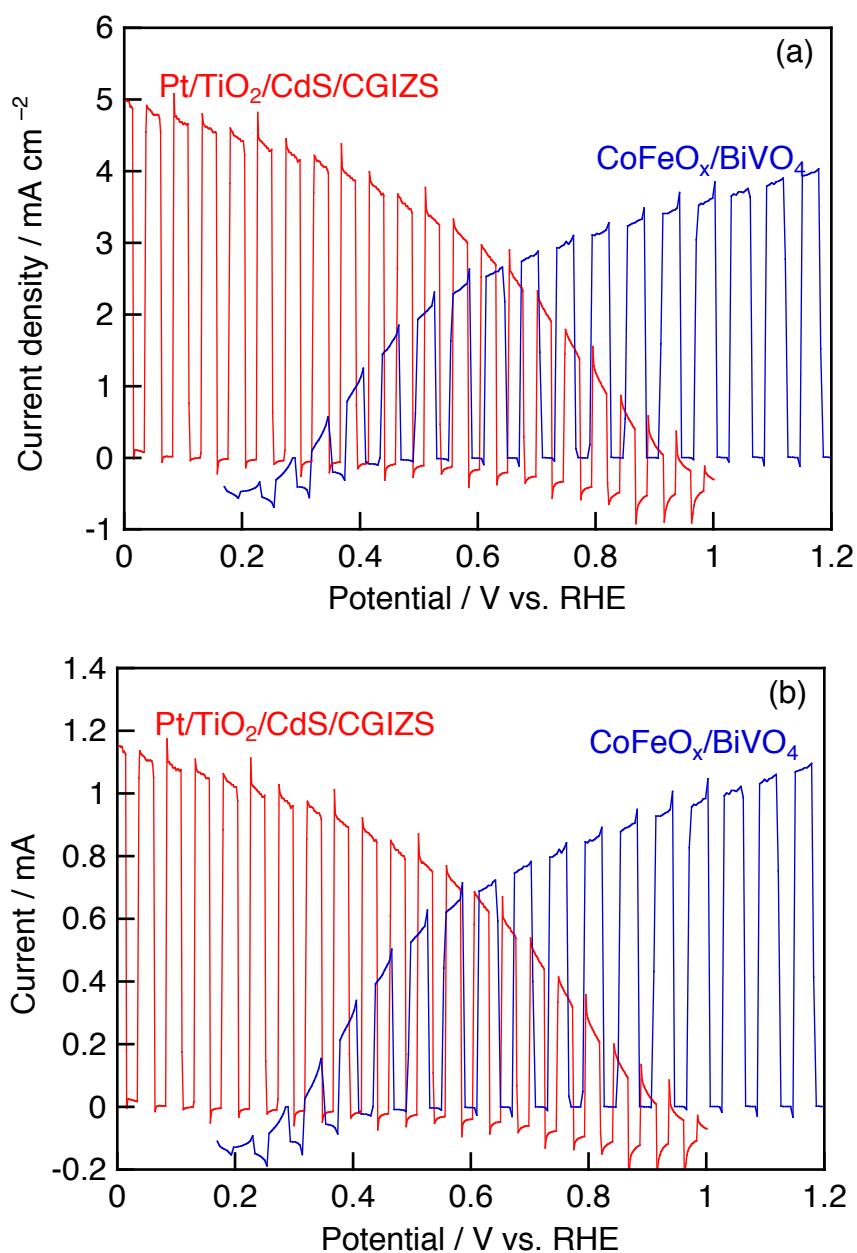
**Figure S8.** XRD patterns of  $(\text{CuGa}_{1-y}\text{In}_y)_{0.8}\text{Zn}_{0.4}\text{S}_2$  photocatalysts ( $y=0.0, 0.25, 0.5, 0.75, 1.0$  and Ga 20% excess) prepared by solid-state synthesis at 1073 K for 10 h.



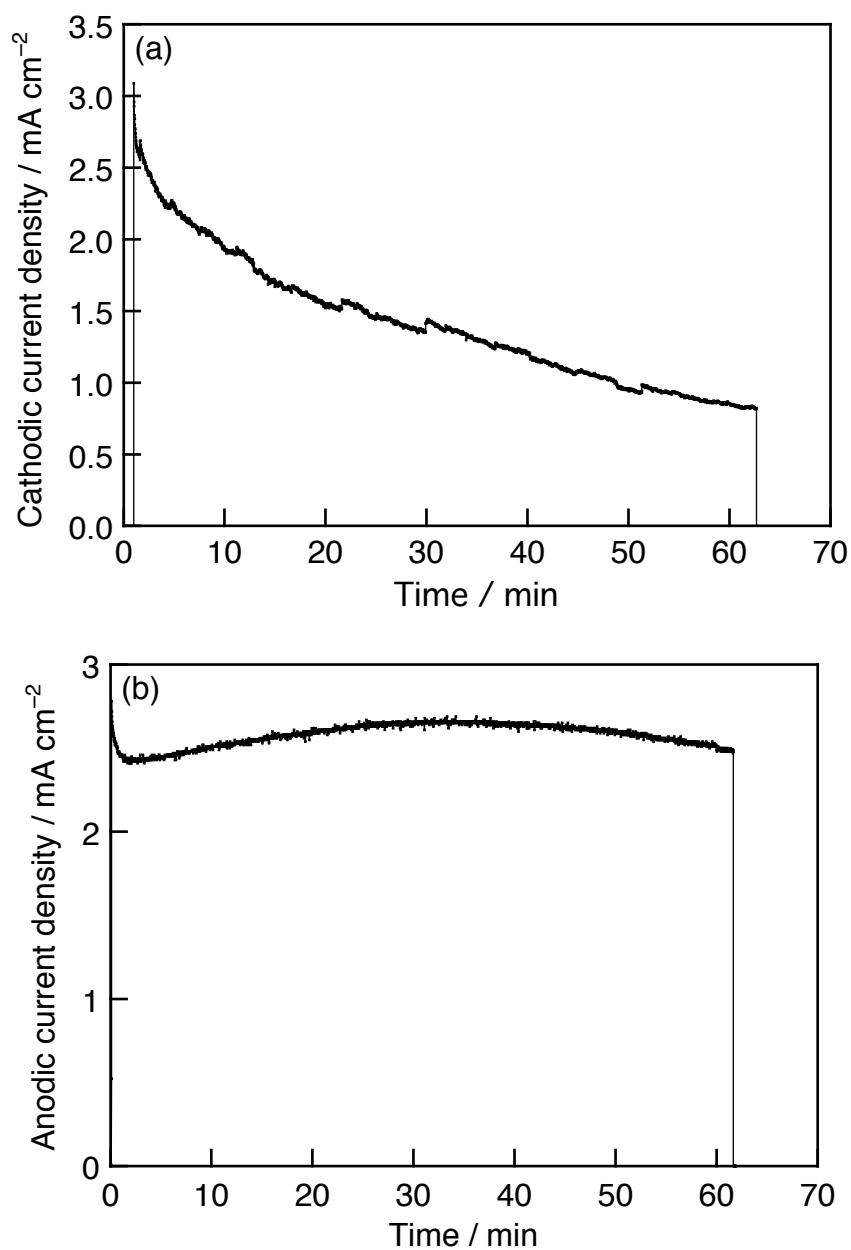
**Figure S9.** SEM image of Cu<sub>0.8</sub>Ga<sub>0.4</sub>In<sub>0.4</sub>Zn<sub>0.4</sub>S<sub>2</sub> photocatalyst (Ga 20% excess) prepared by solid-state synthesis at 1073 K for 10 h.



**Figure S10.** *I-V* curves of Pt/CdS/CGIZS photoelectrodes under simulated sunlight irradiation. The CGIZS photocatalysts ( $\text{Cu}_{0.8}\text{Ga}_{0.4}\text{In}_{0.4}\text{Zn}_{0.4}\text{S}_2$ , Ga 20% excess) were prepared by a flux method using LiCl-KCl (3:2) mixture at 823 K for 15 h and by a solid-state synthesis at 1073 K for 10 h. Electrolyte, aqueous phosphate buffer solution ( $0.5 \text{ mol L}^{-1}$  of  $\text{Na}_2\text{SO}_4$  +  $0.25 \text{ mol L}^{-1}$  of  $\text{NaH}_2\text{PO}_4$  +  $0.25 \text{ mol L}^{-1}$  of  $\text{Na}_2\text{HPO}_4$ ) with pH 6.4; light source, solar simulator (AM 1.5G).

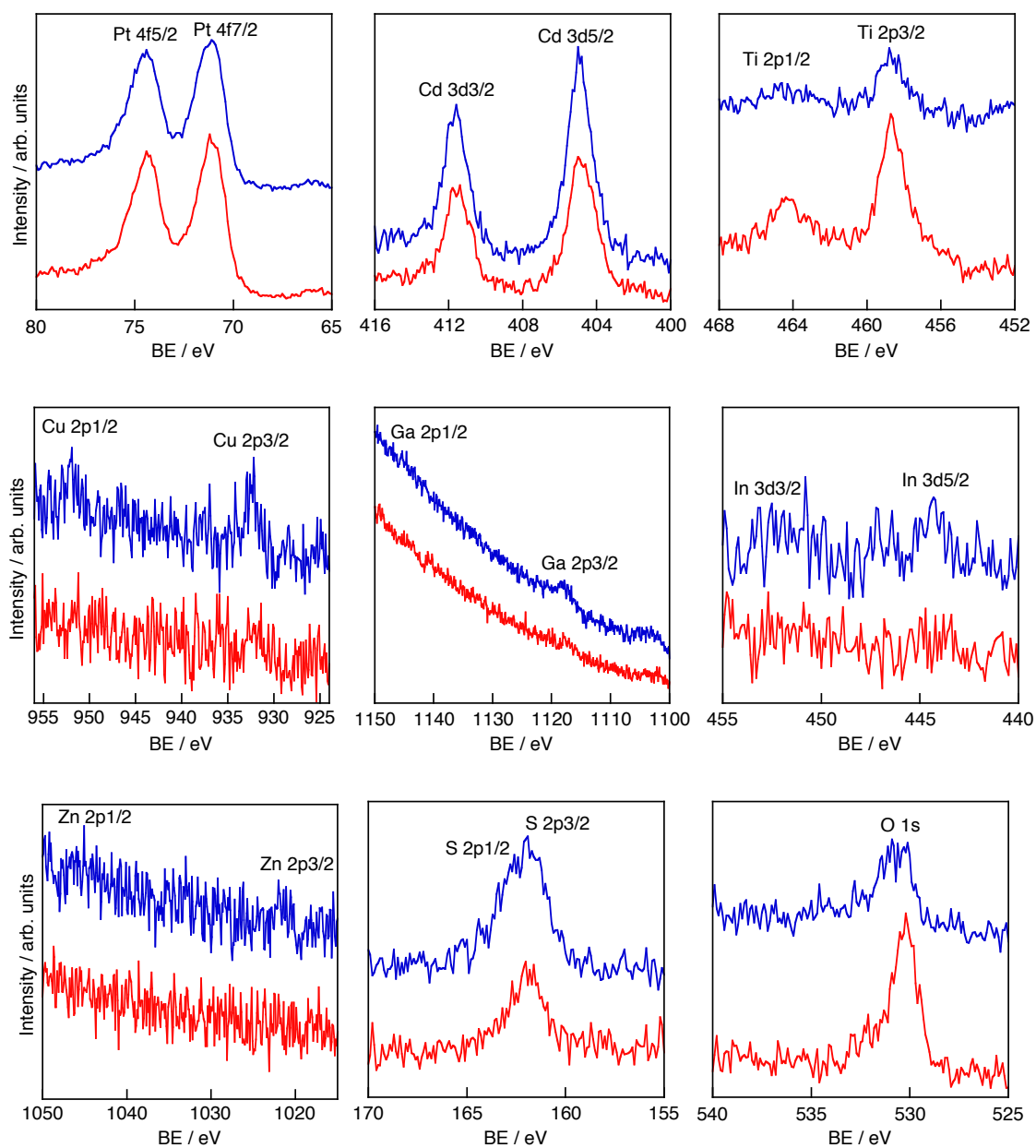


**Figure S11.** (a) Current density-potential and (b) current-potential curves of Pt/TiO<sub>2</sub>/CdS/CGIZS and CoFeO<sub>x</sub>/BiVO<sub>4</sub> photoelectrodes under simulated sunlight irradiation. In (b), the irradiated areas of Pt/TiO<sub>2</sub>/CdS/CGIZS and CoFeO<sub>x</sub>/BiVO<sub>4</sub> were considered to be 0.231 and 0.272 cm<sup>2</sup>. Electrolyte, aqueous phosphate buffer solution (0.5 mol L<sup>-1</sup> of Na<sub>2</sub>SO<sub>4</sub> + 0.25 mol L<sup>-1</sup> of NaH<sub>2</sub>PO<sub>4</sub> + 0.25 mol L<sup>-1</sup> of Na<sub>2</sub>HPO<sub>4</sub>) with pH 7.0; light source, solar simulator (AM 1.5G).



**Figure S12.** Durability test of (a) Pt/TiO<sub>2</sub>/CdS/CGIZS/Au and (b) CoFeO<sub>x</sub>/BiVO<sub>4</sub> photoelectrodes under simulated sunlight irradiation.

Electrolyte, aqueous phosphate buffer solution (0.5 mol L<sup>-1</sup> of Na<sub>2</sub>SO<sub>4</sub> + 0.25 mol L<sup>-1</sup> of NaH<sub>2</sub>PO<sub>4</sub> + 0.25 mol L<sup>-1</sup> of Na<sub>2</sub>HPO<sub>4</sub>) with pH 7.0; light source, solar simulator (AM 1.5G).



**Figure S13.** XPS spectra of Pt, Cd, Ti, Cu, Ga, In, Zn, S, and O in a Pt/TiO<sub>2</sub>/CdS/CGIZS/Au photoelectrode before (red) and after (blue) durability test (Figure S12).

**Table S1.** Current densities and onset potentials in j-V curves of various CGIZS photocathodes (Pt/CdS/CGIZS/Au) with excess elements under chopped simulated sunlight (AM 1.5G)

Excess elements / at%			Current density / mA cm <sup>-2</sup>			Onset potential
Ga	In	Zn	0.0 V <sub>RHE</sub>	0.4 V <sub>RHE</sub>	0.8 V <sub>RHE</sub>	/V <sub>RHE</sub>
0	0	0	0.9	0.5	0.0	0.7
20	0	0	4.6	4.3	1.4	1.0
30	0	0	4.1	3.8	1.0	1.0
0	20	0	3.6	3.3	0.6	0.9
0	30	0	2.7	2.3	0.6	1.0
0	0	20	4.9	1.4	0.0	0.7
20	20	0	1.4	1.2	0.4	1.0
20	0	20	1.6	1.5	0.6	1.0
0	20	20	2.8	2.5	0.1	0.9

The CGIZS (Cu<sub>0.8</sub>Ga<sub>0.4</sub>In<sub>0.4</sub>Zn<sub>0.4</sub>S<sub>2</sub>) photocatalysts with various excess elements of Ga, In or Zn were prepared by a flux method using LiCl-KCl (3:2) mixture at 823 K for 15 h. An aqueous phosphate buffer solution (0.5 mol L<sup>-1</sup> of Na<sub>2</sub>SO<sub>4</sub> + 0.25 mol L<sup>-1</sup> of NaH<sub>2</sub>PO<sub>4</sub> + 0.25 mol L<sup>-1</sup> of Na<sub>2</sub>HPO<sub>4</sub>) with pH 6.4 was used as the electrolyte.